

Features

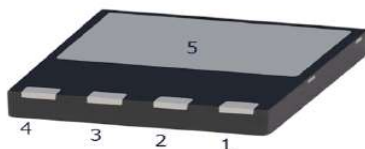
- CRM(CQ) Super_Junction technology
- Much lower Ron*A performance for On-state efficiency
- Much lower FOM for fast switching efficiency

Applications

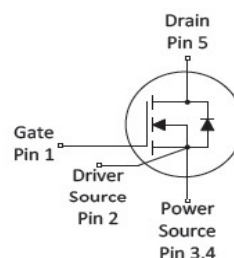
- LED/LCD/PDP TV and monitor Lighting
- Solar/Renewable/UPS-Micro Inverter System
- Charger
- Power Supply

Product Summary

VDS	650V
R _{DS(on)_typ}	183mΩ
I _D	19A

100% DVDS Tested
100% Avalanche Tested


CRJL190N65GCF


Package Marking and Ordering Information

Part #	Marking	Package	Packing	Reel Size	Tape Width	Qty
CRJL190N65GCF	-	DFN8*8	Tape&Reel	N/A	N/A	3000pcs

Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
Drain-source voltage	V _{DS}	650	V
Continuous drain current T _C = 25°C T _C = 100°C	I _D	19 12	A
Pulsed drain current (T _C = 25°C, t _p limited by T _{jmax})	I _{D pulse}	74	A
Avalanche energy, single pulse (L=30mH, Rg=30Ω)	E _{AS}	320	mJ
Gate-Source voltage	V _{GS}	±30	V
Power dissipation (T _C = 25°C)	P _{tot}	144	W
Operating junction and storage temperature	T _j , T _{stg}	-55...+150	°C

Thermal Resistance

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		
Thermal resistance, junction – case. Max	RthJC	-	0.62	0.9	°C/W	
Thermal resistance, junction – ambient. Max	RthJA	-	-	49	°C/W	

Electrical Characteristic (at Tj = 25 °C, unless otherwise specified)

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		

Static Characteristic

Drain-source breakdown voltage	BV _{DSS}	650	-	-	V	V _{GS} =0V, I _D =250uA
Gate threshold voltage	V _{GS(th)}	3.5	-	4.5	V	V _{DS} =V _{GS} , I _D =250uA
Zero gate voltage drain current	I _{DSS}	-	-	5	μA	V _{DS} =650V, V _{GS} =0V
		-	1000	-		T _C =150°C
Gate-source leakage current	I _{GSS}	-	-	±100	nA	V _{GS} =±30V, V _{DS} =0V
Drain-source on-state resistance	R _{DS(on)}	-	183	210	mΩ	V _{GS} =10V, I _D =10A,
		-	487	-		T _C =150°C
Transconductance	g _{fs}	-	16	-	S	V _{DS} =20V, I _D =10A

Dynamic Characteristic

Input Capacitance	C _{iss}	-	1476	-	pF	V _{GS} =0V, V _{DS} =100V, f=1MHz
Output Capacitance	C _{oss}	-	59	-		
Reverse Transfer Capacitance	C _{rss}	-	0.12	-		
Gate Total Charge	Q _G	-	40	-	nC	V _{GS} =10V, V _{DS} =520V, I _D =10A, f=1MHz
Gate-Source charge	Q _{gs}	-	11	-		
Gate-Drain charge	Q _{gd}	-	23	-		
Turn-on delay time	t _{d(on)}	-	27	-	ns	T _j =25°C, V _{GS} =10V, I _D =20A, V _{DS} =325V, R _g =10Ω
Rise time	t _r	-	137	-		
Turn-off delay time	t _{d(off)}	-	50	-		
Fall time	t _f	-	39	-		
Gate resistance	R _G	-	1	-	Ω	V _{GS} =0V, V _{DS} =0V, f=1MHz

Body Diode Characteristic

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		
Body Diode Forward Voltage	V_{SD}	0.7	0.87	1.2	V	$V_{GS}=0V, I_{SD}=10A$
Body Diode Reverse Recovery Time	t_{rr}	-	170	-	ns	$I_{sd}=20A$ $dI/dt=100A/us,$ $V_{ds}=100V$
Body Diode Reverse Recovery Charge	Q_{rr}	-	1025	-	uC	

Typical Performance Characteristics

Fig 1. Output Characteristics (Tj=25°C)

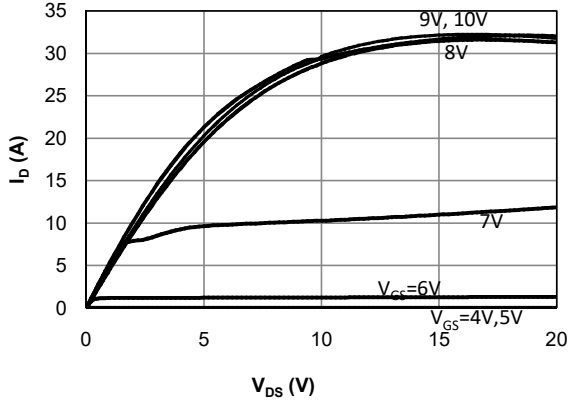


Fig 2. Output Characteristics (Tj=150°C)

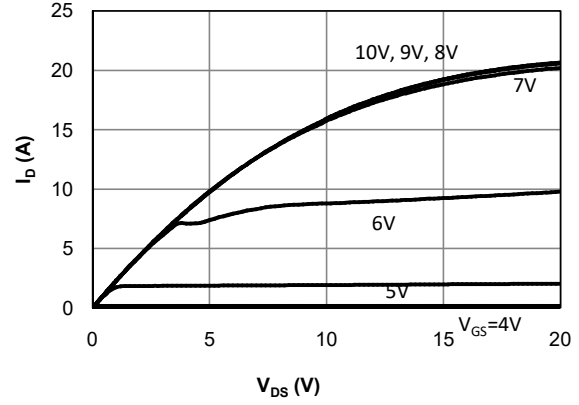


Fig 3: Transfer Characteristics

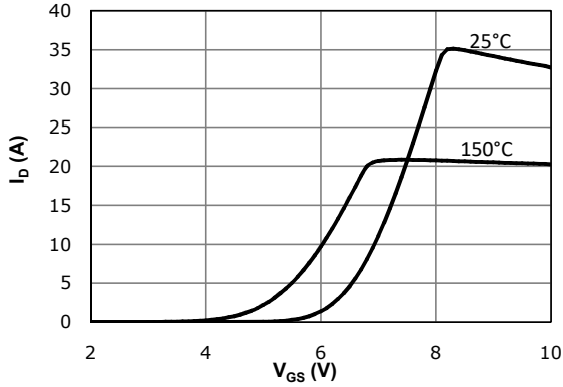


Fig 4: V_{TH} Vs Tj Temperature Characteristics

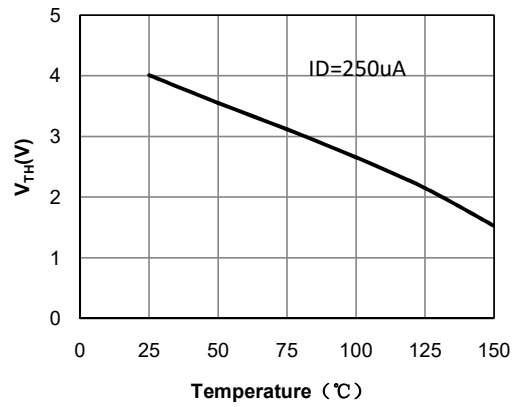


Fig 5: R_{DS(on)} Vs Ids Characteristics

Ta=25V

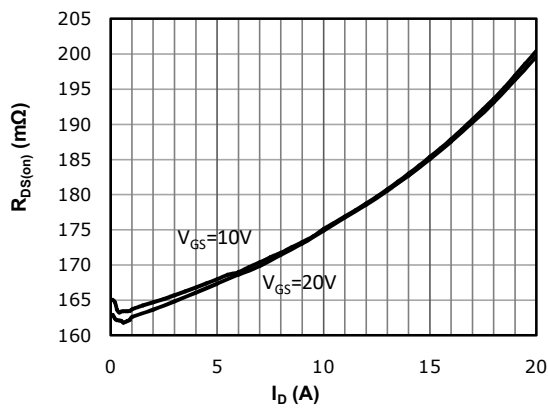


Fig 6: R_{DS(on)} vs. Temperature

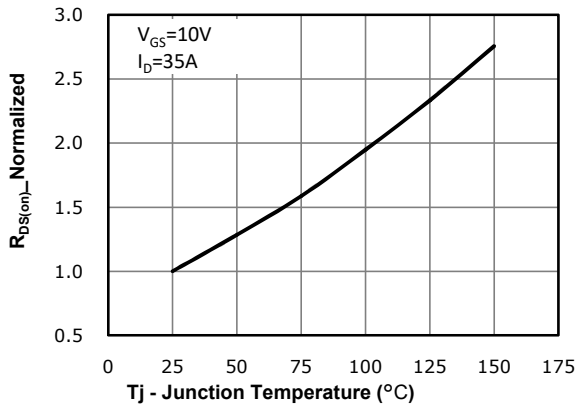


Fig 7: BVdss vs. Temperature

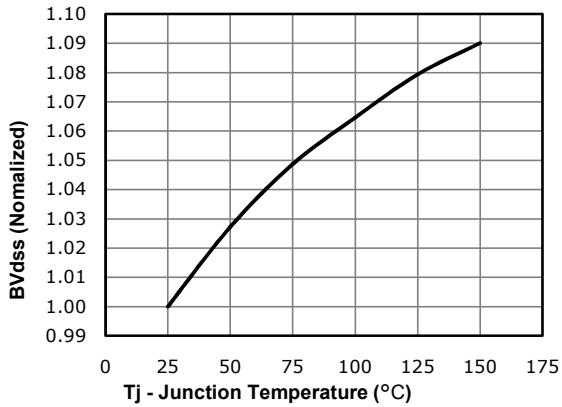


Fig 8: Rds(on) vs Gate Voltage

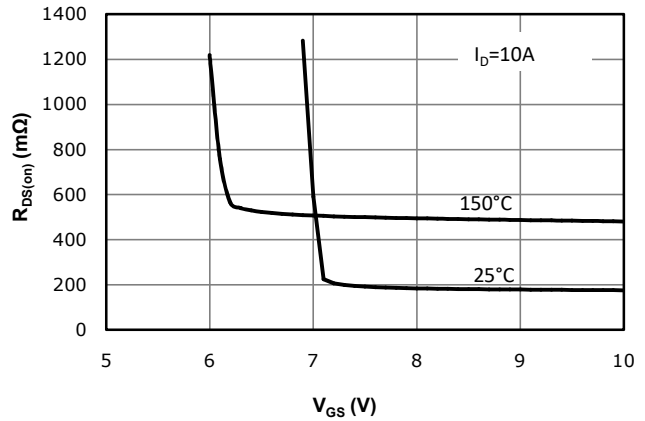


Fig 9: Body-diode Forward Characteristics

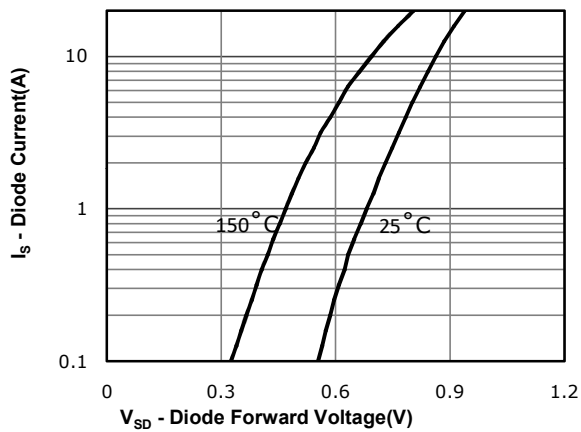


Fig 10: Gate Charge Characteristics

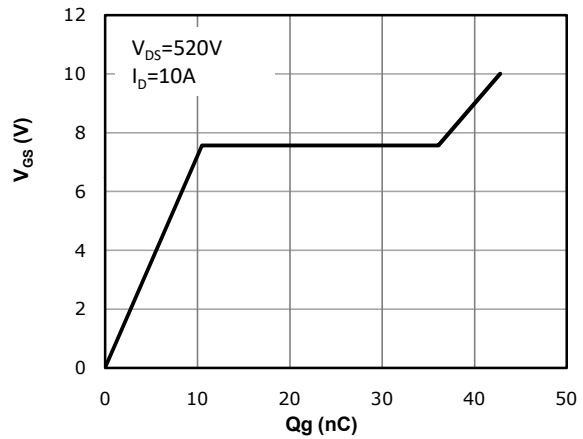


Fig 11: Capacitance Characteristics

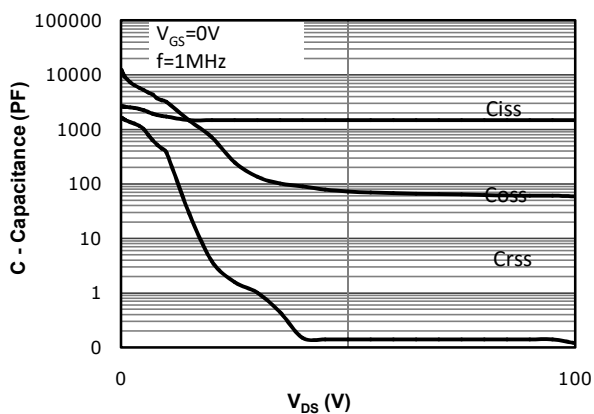


Fig 12: Safe Operating Area

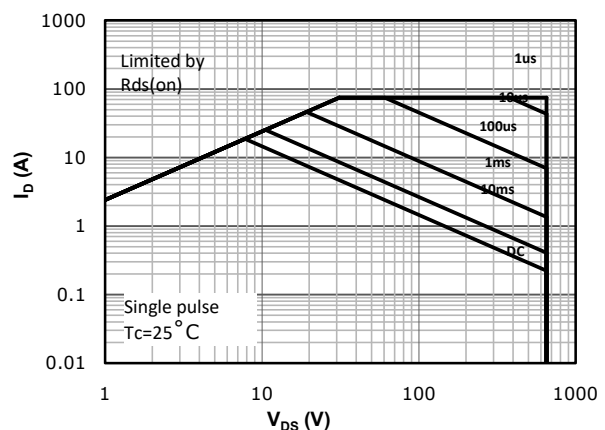
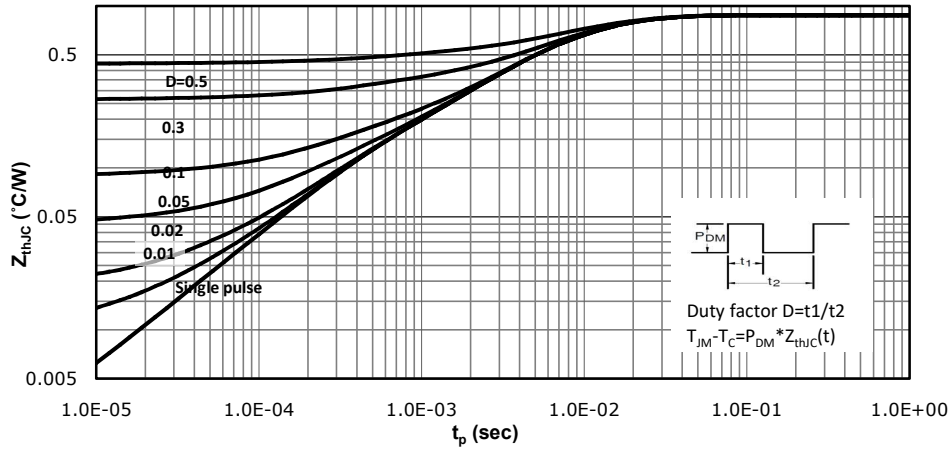
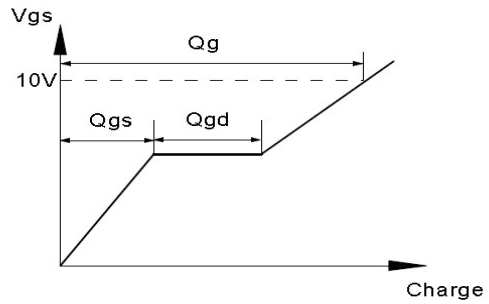
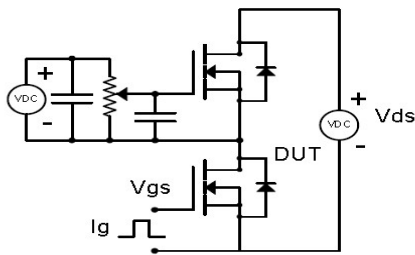


Fig 13: Max. Transient Thermal Impedance

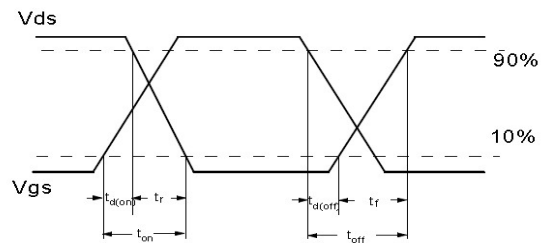
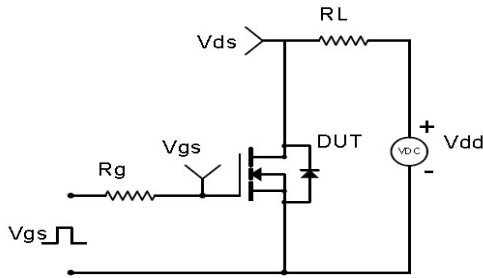


Test Circuit & Waveform

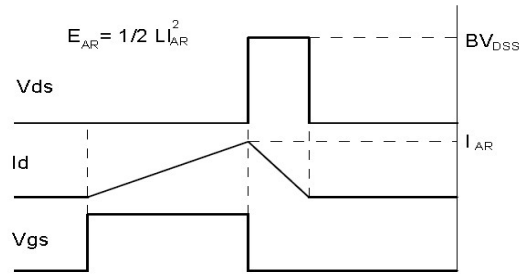
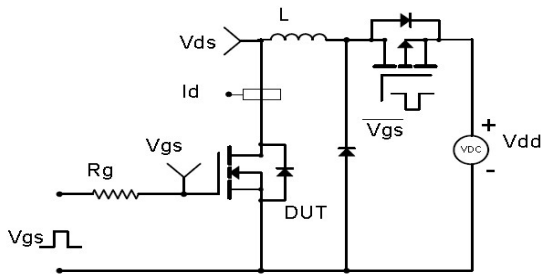
Gate Charge Test Circuit & Waveform



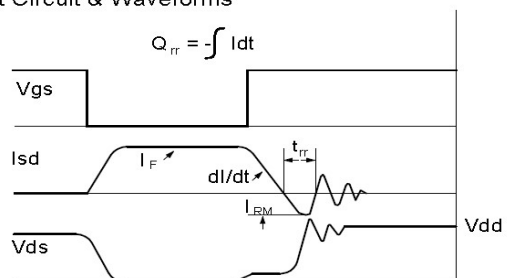
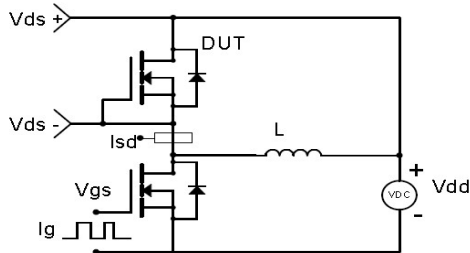
Resistive Switching Test Circuit & Waveforms



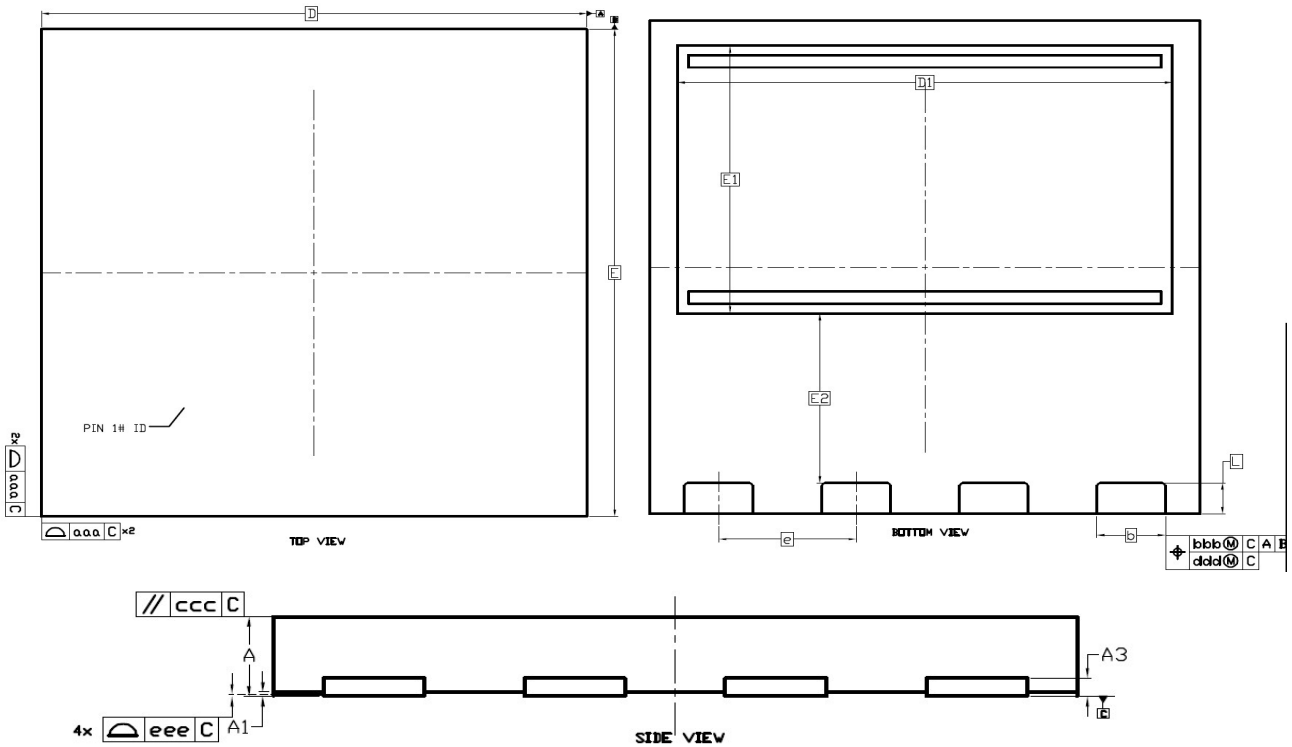
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms



Package Outline: DFN8*8



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.75	0.95	0.030	0.037
A1	0.00	0.05	0.000	0.002
A3	0.203 REF		0.008	
D	8.00		0.300	
E	8.00		0.300	
D1	7.10	7.30	0.280	0.287
E1	4.25	4.45	0.167	0.175
E2	2.65	2.85	0.104	0.112
e	2.00		0.079	
b	0.90	1.10	0.035	0.043
L	16.00	18.00	0.630	0.709
D2	0.40	0.60	0.016	0.024
aaa	0.15		0.006	
bbb	0.10		0.004	
ccc	0.10		0.004	
ddd	0.05		0.002	
eee	0.08		0.003	
fff	0.10		0.004	

Marking



NOTE:	
NXBBAAAAY	
X	—Assembly location code
BB	—Fab code
AAAA	—Lot code
Y	—Bin code

Revision History

Revision	Date	Major changes
1.0	2020-5-22	Release of First draft version

Disclaimer

Unless otherwise specified in the datasheet, the product is designed and qualified as a standard commercial product and is not intended for use in applications that require extraordinary levels of quality and reliability, such as automotive, aviation/aerospace and life-support devices or systems.

Any and all semiconductor products have certain probability to fail or malfunction, which may result in personal injury, death or property damage. Customer are solely responsible for providing adequate safe measures when design their systems.

CRM(CQ) reserves the right to improve product design, function and reliability without notice.

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